IMPACT OF PARTICLES ON SEM AND EVE DATA

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INSTRUMENTS

SOHO-SEM:

- Transmission grating spectrophotometer
 - Order: 0-70 nm (Al filter)
 - 1st-Order: 24-36 nm
- Photodiode detectors
- Orbit: L1 (particles are mainly solar protons)

SDO-EVE:

- Reflection (MEGS) and transmission grating
- CCD and photodiode detectors
- Orbit: Geo (solar protons and trapped electrons)

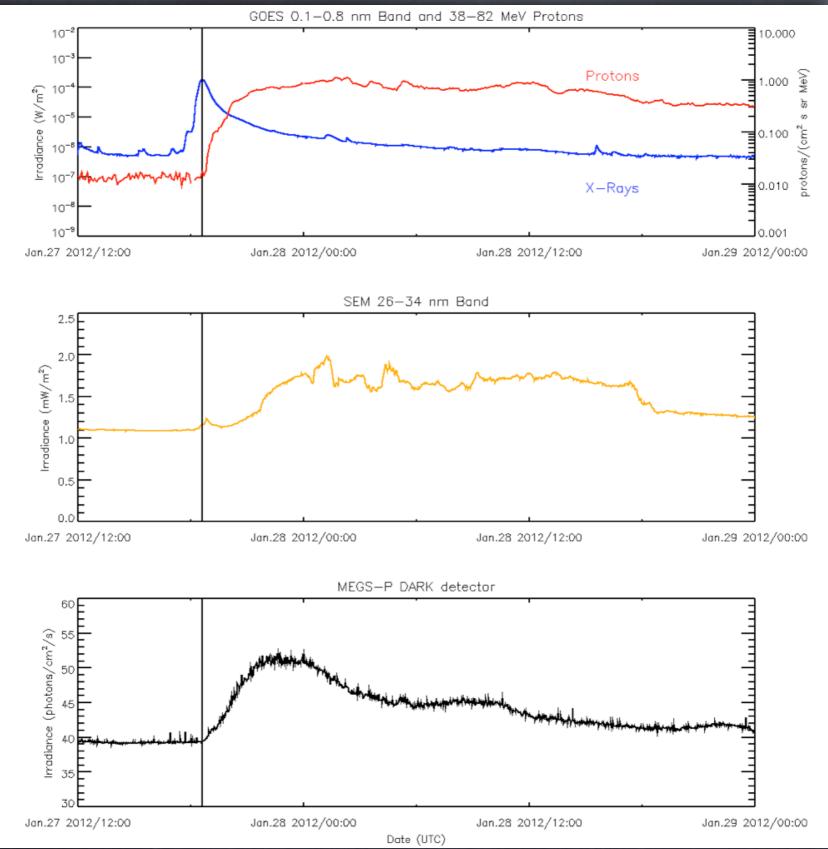
NOISE EFFECTS

Particles create e⁻/h pairs in the detectors just like photons

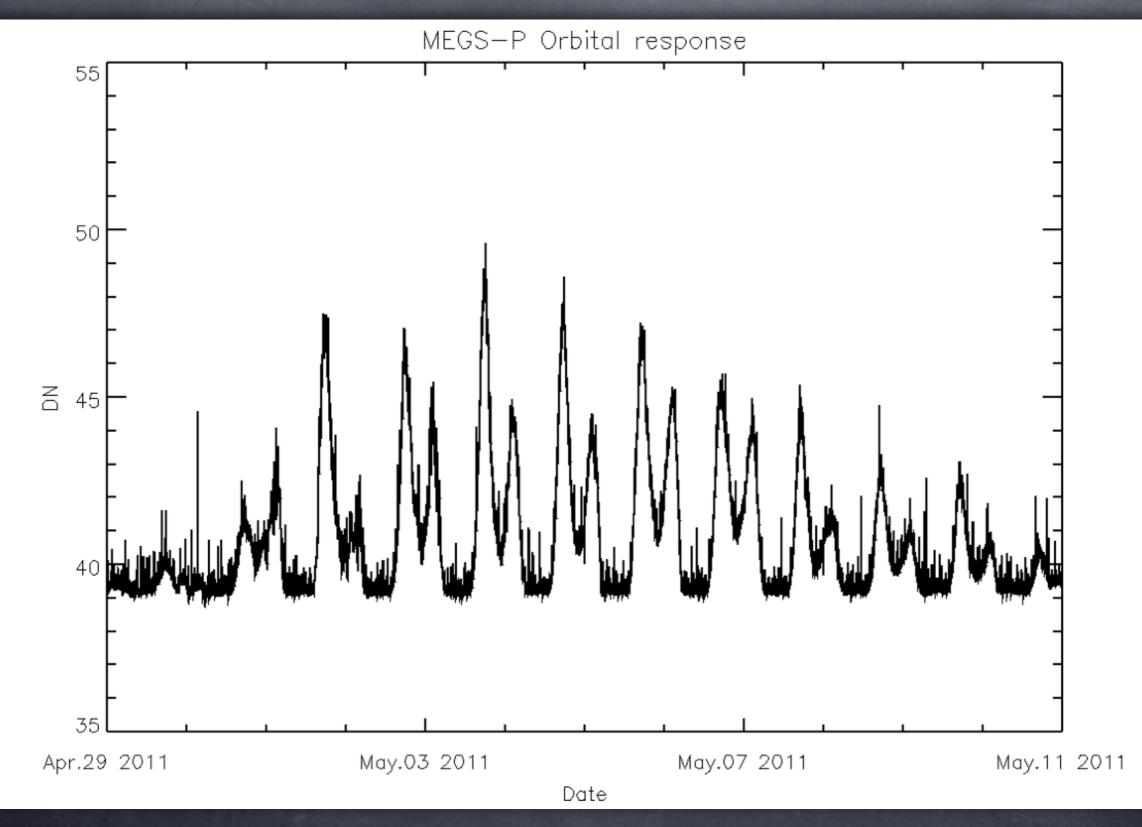
For non-imaging detectors no good way to distinguish between signal from particles and photons without other information

Imaging detectors look for `streaks' and clustered pixels

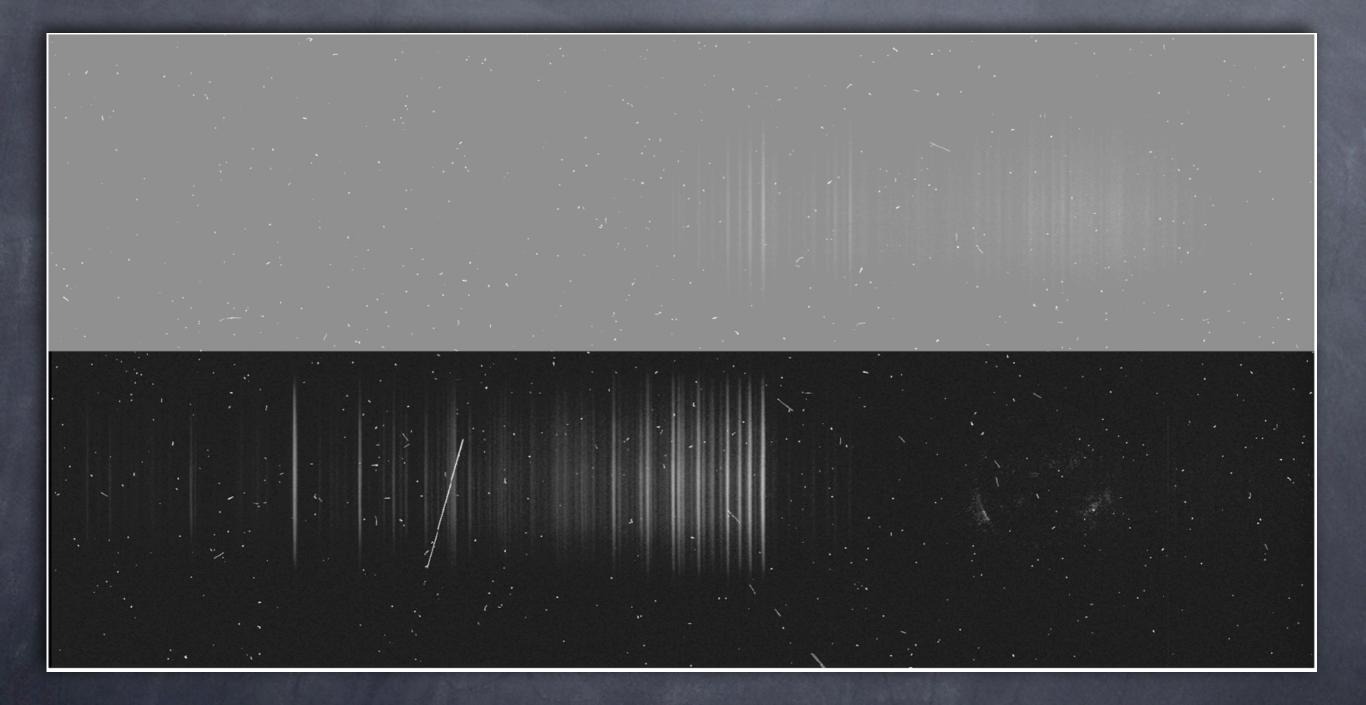
NOISE EFFECTS — DIODES



NOISE EFFECTS - ORBIT



NOISE EFFECTS - CCD



PHOTODIODE DEGRADATION/ DAMAGE

- Si/SiO₂ interface charging
 - Reduced EUV efficiency
 - Nitrideation of interface (IRD/OptoDiode AXUV-G series)
- Rshunt decreases with dose
 - Potentially increased noise
 - Cool detectors to maintain high R_{sh} and low noise
 - Can change other circuit parameters
 - Pre-degrade detectors...

CCD DEGRADATION/DAMAGE

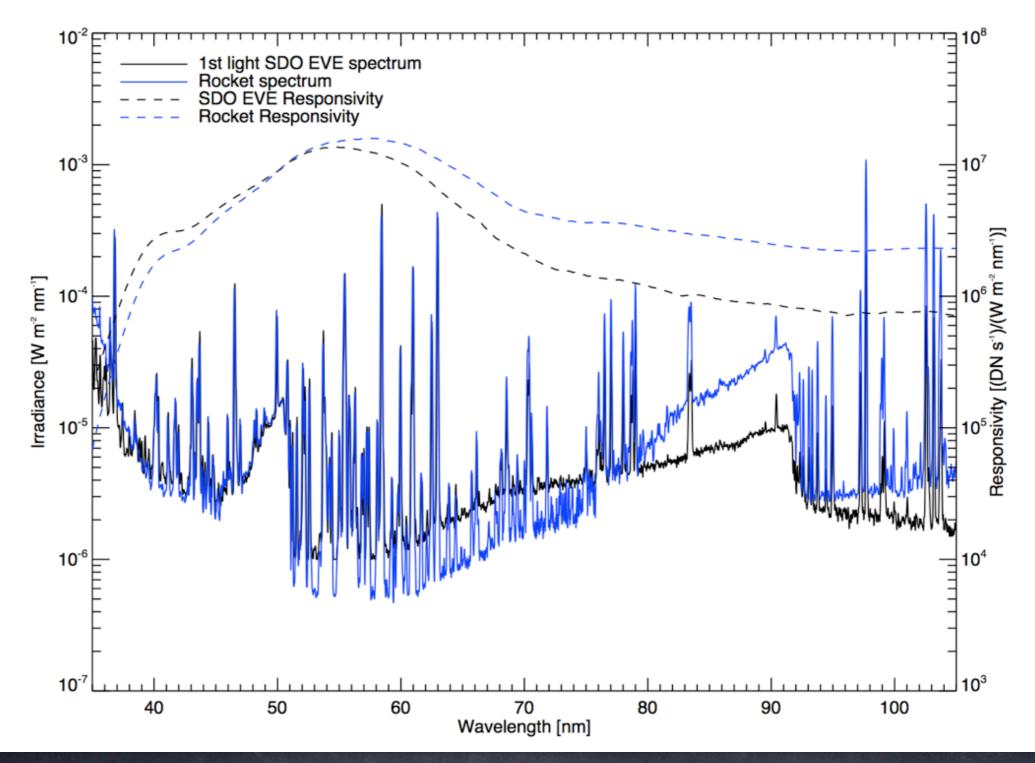
Si/SiO₂ interface charging Reduced EUV efficiency P-type surface implant Lattice Damage Increased noise Cool CCD to increase trap latency Anneal CCDs if possible

EVE CCD INTERFACE CHARGING

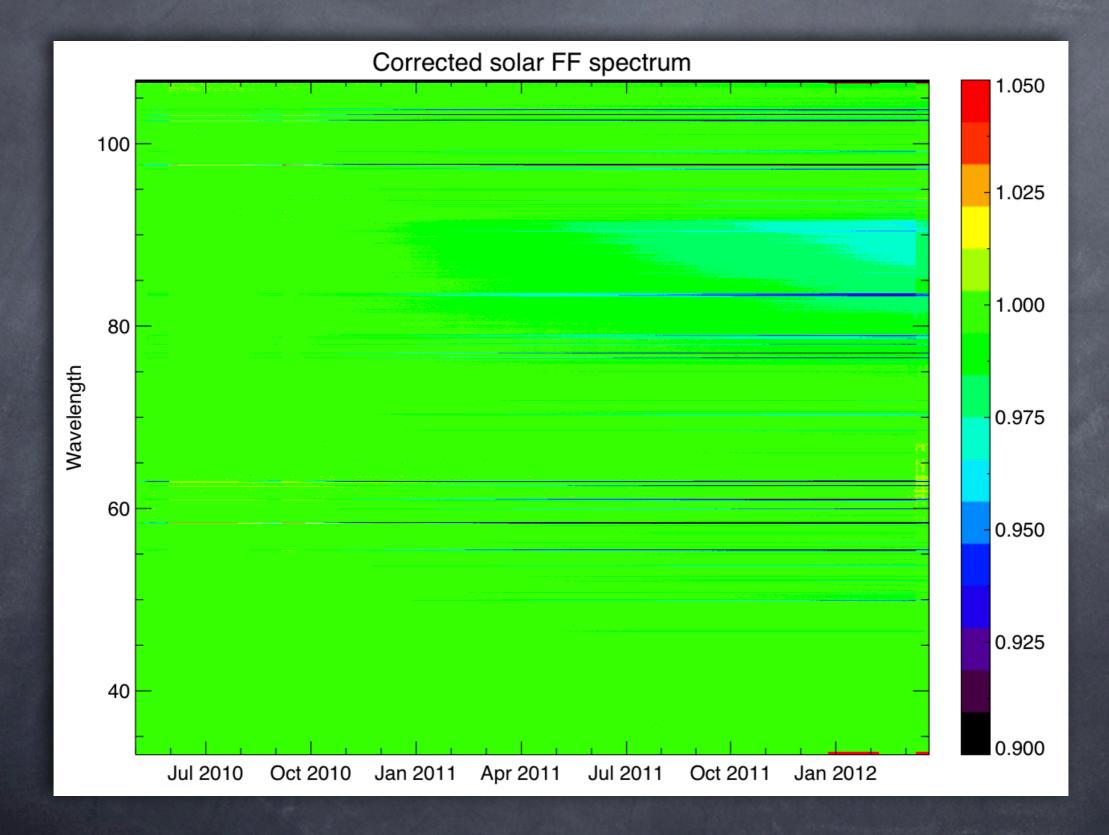
 Significantly reduced first-light sensitivity especially at longer wavelengths)

"Burn-in" of spectral features

MEGS-B FIRST-LIGHT DEGRADATION

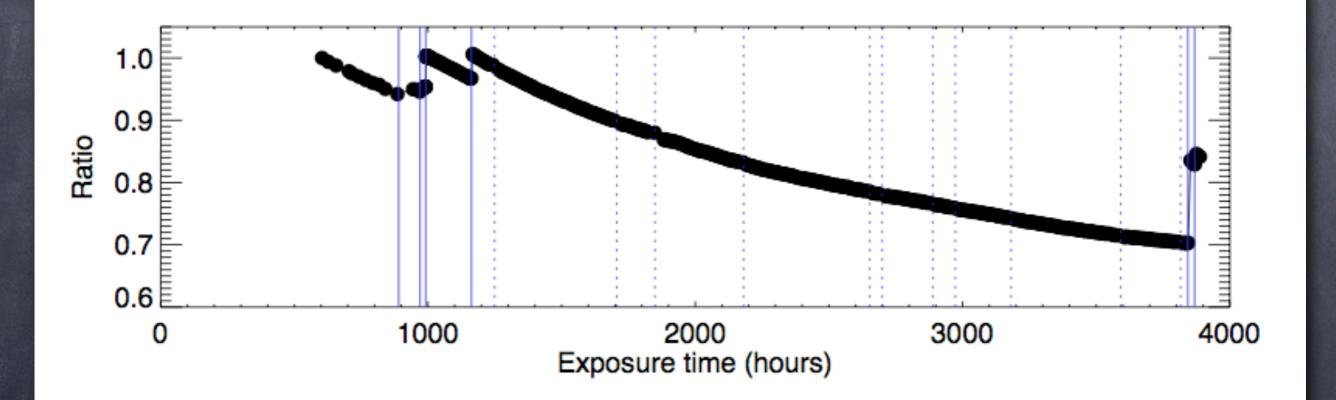


MEGS-B FLAT FIELD



HEATING HELPS A BIT

* 'Bake out' for several hours at about 17°C



SOLUTIONS

Data analysis

- Using external environmental data (SEM)
- "Dark" detector (MEGS-P and ESP)
- Streak removal temporal and spatial median (CCDs)
- Degradation corrections

Shielding

- Mass: LowZ-High-Z (get rid of e⁻ then bremsstrahlung)
- Electrostatic / magnetic for boresights

MODELING AND TESTING

- Simple sheet absorption models:
 - (estar, pstar, SRIM/TRIM)
- Ray tracing with absorption models
 Especially to look for 'holes' in shielding
 Remember to account for the bremsstrahlung
 More sophisticated geometry modeling:
 <u>SPENVIS</u>
 - Multi-Layered Shielding Simulation (MULASSIS)



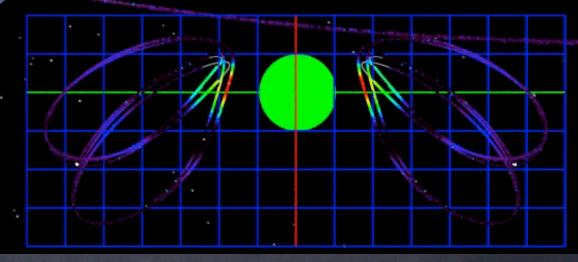
LESSONS LEARNED

Get the shielding right for the environment
Test the CCDs you plan to use
'Dark detectors' work but are not 100% correlated

Resources



EVE MEGS-P GTO



SYMPTOMS OF DIFFERENT **DEGRADATION MECHANISMS** Charging: Contamination:

- Until implanted charge is overcome, QE * is independent of back surface charging
- Completely localized; QE reduced only in * areas of charging
- Charge mobility is low
- If QE reduction is spatially uniform, * implies charging mechanism is spatially uniform
- QE reduction should be temperature * independent

- Likely to be a nearly uniform contamination layer across device
- Implies spatial independence of QE reduction for given λ
- Will charge faster for constant flux than does a clean device
- Charging proportional to the depth of the absorber
- QE reduction may improve with * temperature due to boil-off of material